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| Notice of References Cited | Application/Control No. 10/574,678 | | Applicant(s)/Patent Under Reexamination EDELBROCK, RALF | |
| | Examiner ANNIE MOY | | Art Unit 4147 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-5,016,049 A | 05-1991 | Onishi et al. | 399/32 |
| * | B | US-6,097,444 A | 08-2000 | Nakano, Takao | 348/607 |
| * | C | US-2003/0016297 A1 | 01-2003 | Shigeta, Kazuyuki | 348/304 |
| * | D | US-6,633,286 B1 | 10-2003 | Do et al. | 345/205 |
| * | E | US-2005/0134557 A1 | 06-2005 | Feng et al. | 345/156 |
| * | F | US-2005/0156867 A1 | 07-2005 | Edelbrock, Ralf | 345/102 |
| * | G | US-2005/0283344 A1 | 12-2005 | Moscovitch, Jerry | 702/189 |
| * | H | US-2007/0085816 A1 | 04-2007 | Evanicky et al. | 345/102 |
| * | I | US-2007/0273290 A1 | 11-2007 | Ashdown et al. | 315/113 |
| * | J | US-2007/0279384 A1 | 12-2007 | Brosnan, Michael J. | 345/166 |
| * | K | US-2008/0094081 A1 | 04-2008 | Nguyen et al. | 324/750 |
| * | L | US-2008/0123908 A1 | 05-2008 | Waldman et al. | 382/124 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | I | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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